

03500.014023

PATENT APPLICATION



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

TAMAKI KOBAYASHI ET AL.

Application No.: 09/440,535

Filed: November 16, 1999

For: SUBSTRATE FOR ELECTRON
SOURCE, ELECTRON SOURCE
AND IMAGE FORMING APPARA-
TUS, AND MANUFACTURING
METHOD THEREOF

Examiner: A. Patel

Group Art Unit: 2879

March 23, 2004

Mail Stop RCE
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in
accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is

I hereby certify that this correspondence is being deposited with the
United States Postal Service as first-class mail in an envelope
addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria,
VA 22313-1450 on March 23, 2004.

(Date of Deposit)

FRANK A. DeLUCIA (REG. NO. 42,476)

(Name of Attorney for Applicant)

Signature

March 23, 2004

Date of Signature

directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

For the concise explanation of relevance for non-English document 2630988, the Examiner is respectfully referred to the English Abstract attached thereto and to U.S. Patent 4,954,744, and also to the English Abstract of JP1-298624..

For the concise explanation of relevance for non-English document 2630983, the Examiner is respectfully referred to the English Abstract (attached thereto) of Patent Abstract of Japan No. 01-279538..

For the concise explanation of relevance for non-English document 1-298624, the Examiner is respectfully referred to the English Abstract attached thereto and to U.S. Patent 4,954,744.

For the concise explanation of relevance for non-English document 9-293448, the Examiner is respectfully referred to the English Abstract attached thereto.

For the concise explanation of relevance for non-English document 8-329828, the Examiner is respectfully referred to the English Abstract attached thereto.

For the concise explanation of relevance for non-English document 9-27285, the Examiner is respectfully referred to the English Abstract attached thereto.

For the concise explanation of relevance for non-English document 9-22668, the Examiner is respectfully referred to the English Abstract attached thereto.

For the concise explanation of relevance for non-English document 6-267461, the Examiner is respectfully referred to the English Abstract attached thereto.

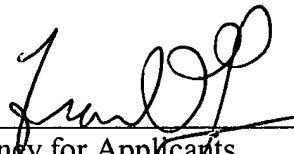
For the concise explanation of relevance for non-English document 1-279538, the Examiner is respectfully referred to the English Abstract attached thereto.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,



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416796v1

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 03500.014023.		APPLICATION NO. 09/440,535		
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			APPLICANT TAMAKI KOBAYASHI ET AL.				
Date Submitted to PTO: [DATE]			FILING DATE NOVEMBER 16, 1999			GROUP 2879	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		4,954,744	9/90	Suzuki et al.	313	336	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
		2630988	4/97	JAPAN			ABSTRACT
		2630983	4/97	JAPAN			ABSTRACT
		1-298624	12/89	JAPAN			ABSTRACT
		9-293448	11/97	JAPAN			ABSTRACT
		8-329828	12/96	JAPAN			ABSTRACT
		9-27285	1/97	JAPAN			ABSTRACT
		9-22668	1/97	JAPAN			ABSTRACT
		6-267461	9/94	JAPAN			ABSTRACT
		1-279538	11/89	JAPAN			ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.